## WHAT IS CLAIMED IS:

1. A tray transfer apparatus comprising:

a transfer plate, the transfer plate including

a plurality of tray holders arranged and configured for the selective support and release of a tray, the tray including an array of pockets for receiving semiconductor devices;

an array of detecting means arranged and configured to detect the presence of more than one semiconductor device in one of the pockets of a supported tray;

wiring means connecting the detecting means to an input/output terminal; and

driving means arranged and configured for controlled vertical and horizontal movement of the transfer plate.

2. The tray transfer apparatus according to claim 1, wherein: the detecting means are detecting switches.

3. The tray transfer apparatus according to claim 2, wherein:

the detecting switches are mechanical contact type push-button switches, and

the detecting switches included in the array of detecting means are connected in a parallel configuration.

4. The tray transfer apparatus according to claim 2, wherein:

the transfer plate includes a top surface, a bottom surface and an array of installation holes extending through the transfer plate; and further wherein

the detecting switches extend through the installation holes and below a plane defined by the bottom surface of the transfer plate.

5. The tray transfer apparatus according to claim 4, further comprising: a detecting substrate, the detecting substrate having an upper surface

the detecting switches are arranged on the lower surface of the detecting substrate; and

the detecting substrate is mounted on the top surface of the transfer

and a lower surface, wherein

plate, thereby extending the detecting switches through the installation holes.

6. The tray transfer apparatus according to claim 5, wherein:

the detecting switches are mounted on the lower surface of the detecting substrate by a method selected from soldering and friction fit.

7. The tray transfer apparatus according to claim 1, wherein:

the transfer plate includes a rotatable member arranged at a periphery of the transfer plate and extending above and below the transfer plate;

a catch finger connected to a lower extension of the rotatable member;

an actuation means connected to an upper extension of the rotatable member, whereby the rotatable member may be selectively rotated to move the catch finger between a supporting position and a releasing position.

8. The tray transfer apparatus according to claim 2, further comprising:

a control substrate for generating a control signal, the control signal corresponding to an activation status of the detecting switches.

9. The tray transfer apparatus according to claim 8, wherein:

the control substrate further includes a flashing circuit arranged and configured to generate flash signals corresponding to the activation status of the detecting switches.

- 10. The tray transfer apparatus according to claim 9, wherein:
  the flashing circuit includes a NE555 circuit.
- 11. The tray transfer apparatus according to claim 8, wherein:
  the control substrate includes a direct current to alternating current rectifier.
- 12. An automatic test handler comprising:

a plurality of tray stockers arranged and configured for receiving and positioning trays, the trays including an array of pockets with each pocket being sized and configured to receive and hold a semiconductor device;

a tray transfer unit including a transfer plate arranged and configured to

transfer and position a supported tray, an array of detecting switches arranged and configured to indicate the presence of more than one semiconductor device in a pocket of the supported tray, a detecting substrate and a driving means;

a tester for performing electrical tests on the semiconductor devices;

a first chamber for establishing a first temperature condition in the semiconductor devices under which the semiconductor devices will be tested;

a second chamber for restoring the tested semiconductor device to the normal temperature;

a pick and place device arranged and configured for removing the semiconductor devices from the pockets and for placing the semiconductor devices into the pockets; and

a controller for controlling the stockers, the tester, the tray transfer unit, the pick and place device and the first and second chambers.

- 13. The automatic test handler according to claim 12, wherein: the controller is incorporated within the tray transfer unit.
- 14. The automatic test handler of claim 12, wherein:

the controller generates a test stop signal corresponding to the activation status of the detecting switches.

- 15. The automatic test handler according to claim 12, further comprising:

  an alarm means for generating an alarm signal corresponding to the activation status of the detecting switches.
- 16. The automatic test handler according to claim 12, further comprising:

  a control substrate arranged and configured for providing power to the detecting substrate and for generating flash signals according to the activation status of the detecting switches.